

ON Semiconductor

Is Now



To learn more about onsemi™, please visit our website at
www.onsemi.com

onsemi and **onsemi** and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi does not convey any license under any of its intellectual property rights nor the rights of others. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use onsemi products for any such unintended or unauthorized application, Buyer shall indemnify and hold onsemi and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that onsemi was negligent regarding the design or manufacture of the part. onsemi is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner. Other names and brands may be claimed as the property of others.

NTMFD4C86N

PowerPhase, Dual N-Channel SO8FL 30 V, High Side 20 A / Low Side 32 A

Features

- Co-Packaged Power Stage Solution to Minimize Board Space
- Minimized Parasitic Inductances
- Optimized Devices to Reduce Power Losses
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- DC-DC Converters
- System Voltage Rails
- Point of Load

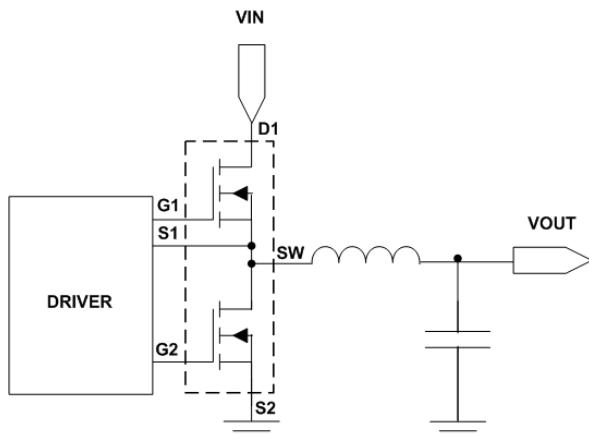


Figure 1. Typical Application Circuit

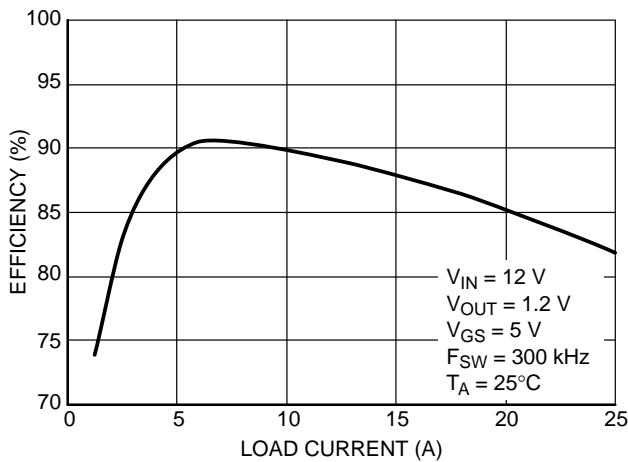


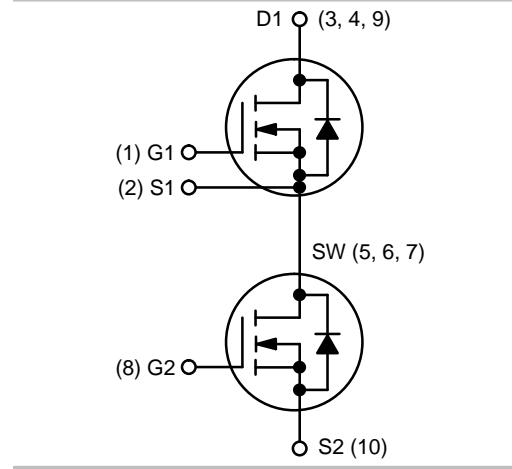
Figure 2. Typical Efficiency Performance
POWERPHASEGEVBOARD



ON Semiconductor®

www.onsemi.com

V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX
Q1 Top FET 30 V	5.4 mΩ @ 10 V	20 A
	8.1 mΩ @ 4.5 V	
Q2 Bottom FET 30 V	2.6 mΩ @ 10 V	32 A
	3.4 mΩ @ 4.5 V	



PIN CONNECTIONS

D1	4	5 SW
D1	3	6 SW
S1	2	7 SW
G1	1	8 G2

(Bottom View)



4C86N = Specific Device Code
A = Assembly Location
Y = Year
W = Work Week
ZZ = Lot Traceability

ORDERING INFORMATION

See detailed ordering and shipping information on page 10 of this data sheet.

NTMFD4C86N

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Parameter	Symbol	Value	Unit			
Drain-to-Source Voltage	V _{DSS}	30	V			
Drain-to-Source Voltage						
Gate-to-Source Voltage	V _{GS}	±20	V			
Gate-to-Source Voltage						
Continuous Drain Current R _{θJA} (Note 1)	Steady State	T _A = 25°C T _A = 85°C	Q1	I _D	14.8 10.7	A
		T _A = 25°C T _A = 85°C			23.7 17.1	
Power Dissipation R _{θJA} (Note 1)		T _A = 25°C	Q1 Q2	P _D	1.89	W
		T _A = 85°C				
Continuous Drain Current R _{θJA} ≤ 10 s (Note 1)		T _A = 25°C T _A = 85°C	Q1	I _D	20.2 14.5	A
		T _A = 25°C T _A = 85°C			32.3 23.3	
Power Dissipation R _{θJA} ≤ 10 s (Note 1)		T _A = 25°C	Q1 Q2	P _D	3.51	W
		T _A = 85°C				
Continuous Drain Current R _{θJA} (Note 2)		T _A = 25°C T _A = 85°C	Q1	I _D	11.3 8.1	A
		T _A = 25°C T _A = 85°C			18.1 13.0	
Power Dissipation R _{θJA} (Note 2)		T _A = 25 °C	Q1 Q2	P _D	1.10	W
		T _A = 85 °C				
Pulsed Drain Current		T _A = 25°C t _p = 10 μs	Q1 Q2	I _{DM}	160 280	A
Operating Junction and Storage Temperature					-55 to +150	
Source Current (Body Diode)		Q1	T _J , T _{STG}	I _S	10	A
		Q2			10	
Drain to Source DV/DT			dV/dt		6	V/ns
Single Pulse Drain-to-Source Avalanche Energy (T _J = 25°C, V _{DD} = 50 V, V _{GS} = 10 V, L = 0.1 mH, R _G = 25 Ω)	I _L = 20 A _{pk} I _L = 40 A _{pk}	Q1 Q2	EAS		20 80	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			T _L		260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Surface-mounted on FR4 board using 1 sq-in pad, 2 oz Cu.
2. Surface-mounted on FR4 board using the minimum recommended pad size of 100 mm².

NTMFD4C86N

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Top) – Steady State (Note 3)	$R_{\theta JC}$	3.3	$^{\circ}\text{C}/\text{W}$
Junction-to-Ambient – Steady State (Note 3)	$R_{\theta JA}$	66.0	
Junction-to-Ambient – Steady State (Note 4)	$R_{\theta JA}$	113.7	
Junction-to-Ambient – (t ≤ 10 s) (Note 3)	$R_{\theta JA}$	35.6	

3. Surface-mounted on FR4 board using 1 sq-in pad, 2 oz Cu.

4. Surface-mounted on FR4 board using the minimum recommended pad size of 100 mm².

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	FET	Symbol	Test Condition	Min	Typ	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Break-down Voltage	Q1	$V_{(\text{BR})\text{DSS}}$	$V_{\text{GS}} = 0 \text{ V}, I_{\text{D}} = 250 \mu\text{A}$	30			V
	Q2			30			
Drain-to-Source Break-down Voltage Temperature Coefficient	Q1	$V_{(\text{BR})\text{DSS}} / T_J$			17		mV / $^{\circ}\text{C}$
	Q2				16.5		
Zero Gate Voltage Drain Current	Q1	I_{DSS}	$V_{\text{GS}} = 0 \text{ V}, V_{\text{DS}} = 24 \text{ V}$	$T_J = 25^{\circ}\text{C}$		1	μA
				$T_J = 125^{\circ}\text{C}$		10	
	Q2		$V_{\text{GS}} = 0 \text{ V}, V_{\text{DS}} = 24 \text{ V}$	$T_J = 25^{\circ}\text{C}$		1	
Gate-to-Source Leakage Current	Q1	I_{GSS}	$V_{\text{GS}} = 0 \text{ V}, V_{\text{DS}} = +20 \text{ V}$			100	nA
	Q2					100	

ON CHARACTERISTICS (Note 5)

Gate Threshold Voltage	Q1	$V_{\text{GS}(\text{TH})}$	$V_{\text{GS}} = V_{\text{DS}}, I_{\text{D}} = 250 \mu\text{A}$	1.3		2.2	V
	Q2			1.3		2.2	
Negative Threshold Temperature Coefficient	Q1	$V_{\text{GS}(\text{TH})} / T_J$			4.5		mV / $^{\circ}\text{C}$
	Q2				4.6		
Drain-to-Source On Resistance	Q1	$R_{\text{DS}(\text{on})}$	$V_{\text{GS}} = 10 \text{ V}$	$I_{\text{D}} = 30 \text{ A}$		4.3	5.4
			$V_{\text{GS}} = 4.5 \text{ V}$	$I_{\text{D}} = 18 \text{ A}$		6.5	8.1
	Q2		$V_{\text{GS}} = 10 \text{ V}$	$I_{\text{D}} = 30 \text{ A}$		1.7	2.6
			$V_{\text{GS}} = 4.5 \text{ V}$	$I_{\text{D}} = 12.5 \text{ A}$		2.4	3.4

CAPACITANCES

Input Capacitance	Q1	C_{ISS}	$V_{\text{GS}} = 0 \text{ V}, f = 1 \text{ MHz}, V_{\text{DS}} = 15 \text{ V}$		1153		pF	
	Q2				3050			
Output Capacitance	Q1	C_{OSS}			532			
	Q2				1650			
Reverse Capacitance	Q1	C_{RSS}			107			
	Q2				77			

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

5. Pulse Test: pulse width ≤ 300 μs , duty cycle ≤ 2%.

6. Switching characteristics are independent of operating junction temperatures.

NTMFD4C86N

ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise specified)

Parameter	FET	Symbol	Test Condition	Min	Typ	Max	Unit	
CHARGES, CAPACITANCES & GATE RESISTANCE								
Total Gate Charge	Q1	$Q_{G(\text{TOT})}$	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V}; I_D = 30 \text{ A}$		10.9		nC	
	Q2				21.6			
Threshold Gate Charge	Q1	$Q_{G(\text{TH})}$			1.2			
	Q2				1.4			
Gate-to-Source Charge	Q1	Q_{GS}			3.4			
	Q2				8.6			
Gate-to-Drain Charge	Q1	Q_{GD}			5.4			
	Q2				5.5			
Total Gate Charge	Q1	$Q_{G(\text{TOT})}$	$V_{GS} = 10 \text{ V}, V_{DS} = 15 \text{ V}; I_D = 30 \text{ A}$		22.2		nC	
	Q2				47.5			
Gate Resistance	Q1	R_G	$T_A = 25^\circ\text{C}$		1.0		Ω	
	Q2				1.0			

SWITCHING CHARACTERISTICS (Note 6)

Turn-On Delay Time	Q1	$t_{d(\text{ON})}$	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V}, I_D = 15 \text{ A}, R_G = 3.0 \Omega$		8.9		ns	
	Q2				8.3			
Rise Time	Q1	t_r			21.2			
	Q2				15.1			
Turn-Off Delay Time	Q1	$t_{d(\text{OFF})}$			15.3			
	Q2				19.3			
Fall Time	Q1	t_f			4.4			
	Q2				4.2			

SWITCHING CHARACTERISTICS (Note 6)

Turn-On Delay Time	Q1	$t_{d(\text{ON})}$	$V_{GS} = 10 \text{ V}, V_{DS} = 15 \text{ V}, I_D = 15 \text{ A}, R_G = 3.0 \Omega$		6.7		ns	
	Q2				6.3			
Rise Time	Q1	t_r			19.5			
	Q2				13.8			
Turn-Off Delay Time	Q1	$t_{d(\text{OFF})}$			20.1			
	Q2				22.8			
Fall Time	Q1	t_f			2.8			
	Q2				3.2			

DRAIN-SOURCE DIODE CHARACTERISTICS

Forward Voltage	Q1	V_{SD}	$V_{GS} = 0 \text{ V}, I_S = 10 \text{ A}$	$T_J = 25^\circ\text{C}$		0.80		V	
	Q2			$T_J = 125^\circ\text{C}$		0.60			
	Q2		$V_{GS} = 0 \text{ V}, I_S = 10 \text{ A}$	$T_J = 25^\circ\text{C}$		0.78			
				$T_J = 125^\circ\text{C}$		0.62			

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

5. Pulse Test: pulse width $\leq 300 \mu\text{s}$, duty cycle $\leq 2\%$.
6. Switching characteristics are independent of operating junction temperatures.

NTMFD4C86N

ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise specified)

Parameter	FET	Symbol	Test Condition	Min	Typ	Max	Unit
DRAIN-SOURCE DIODE CHARACTERISTICS							
Reverse Recovery Time	Q1	t_{RR}	$V_{GS} = 0 \text{ V}, dI_S/dt = 100 \text{ A}/\mu\text{s}, I_S = 30 \text{ A}$		29.1		ns
	Q2				33.7		
Charge Time	Q1	t_a	$V_{GS} = 0 \text{ V}, dI_S/dt = 100 \text{ A}/\mu\text{s}, I_S = 30 \text{ A}$		14.5		ns
	Q2				17.4		
Discharge Time	Q1	t_b	$V_{GS} = 0 \text{ V}, dI_S/dt = 100 \text{ A}/\mu\text{s}, I_S = 30 \text{ A}$		14.6		ns
	Q2				16.3		
Reverse Recovery Charge	Q1	Q_{RR}	$V_{GS} = 0 \text{ V}, dI_S/dt = 100 \text{ A}/\mu\text{s}, I_S = 30 \text{ A}$		21		nC
	Q2				27.5		

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

5. Pulse Test: pulse width $\leq 300 \mu\text{s}$, duty cycle $\leq 2\%$.

6. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS – Q1

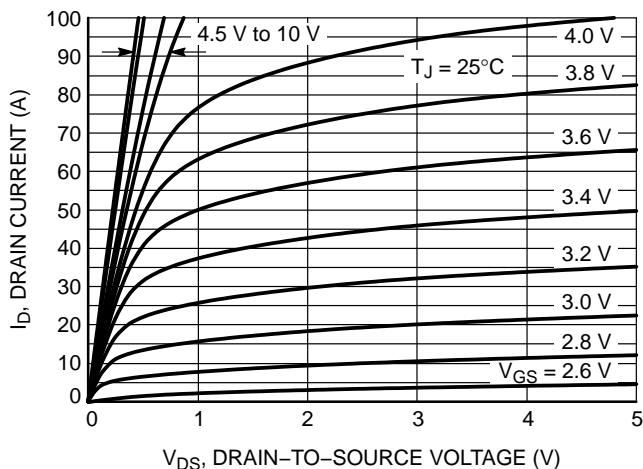


Figure 3. On-Region Characteristics

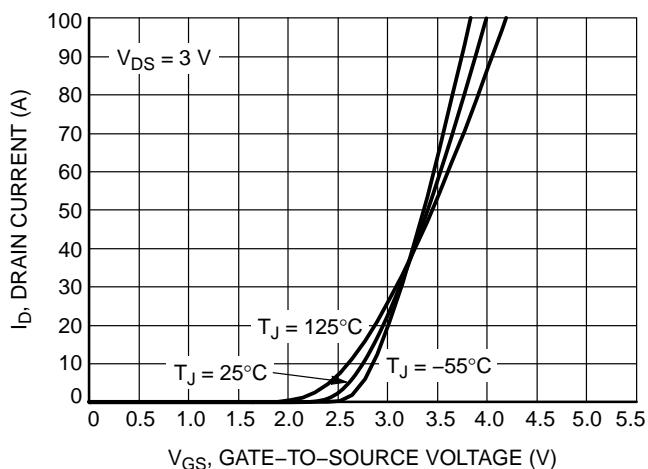


Figure 4. Transfer Characteristics

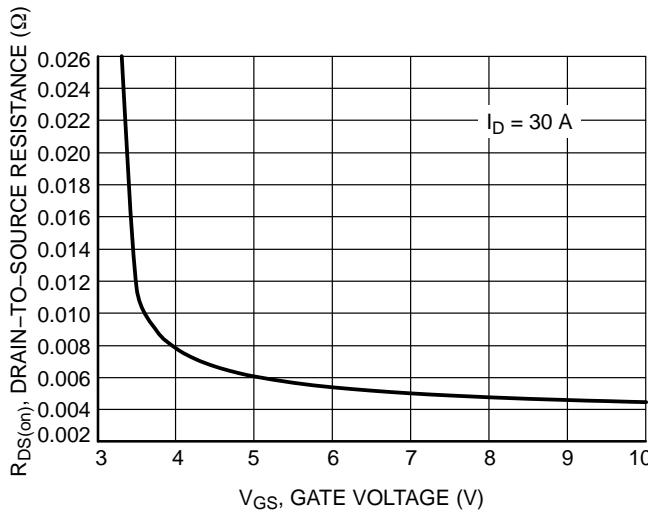


Figure 5. On-Resistance vs. Gate-to-Source Voltage

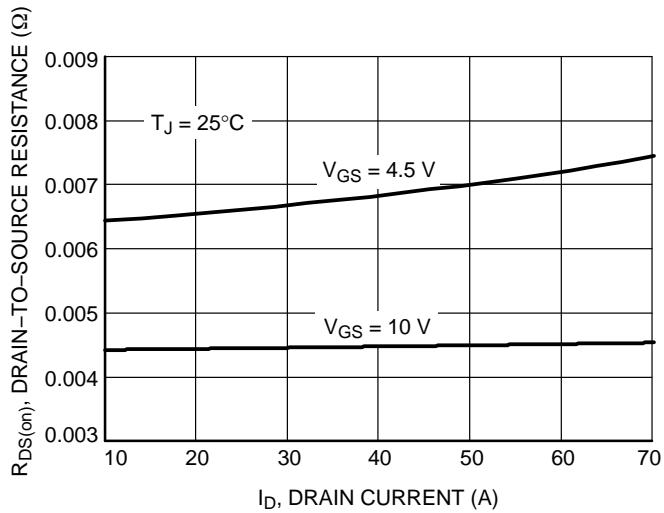


Figure 6. On-Resistance vs. Drain Current and Gate Voltage

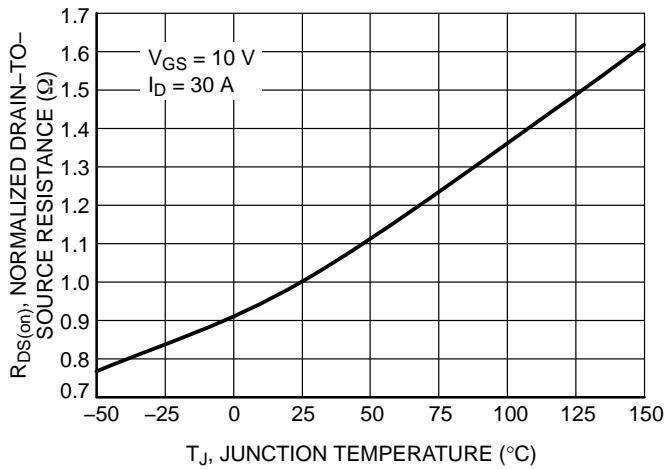


Figure 7. On-Resistance Variation with Temperature

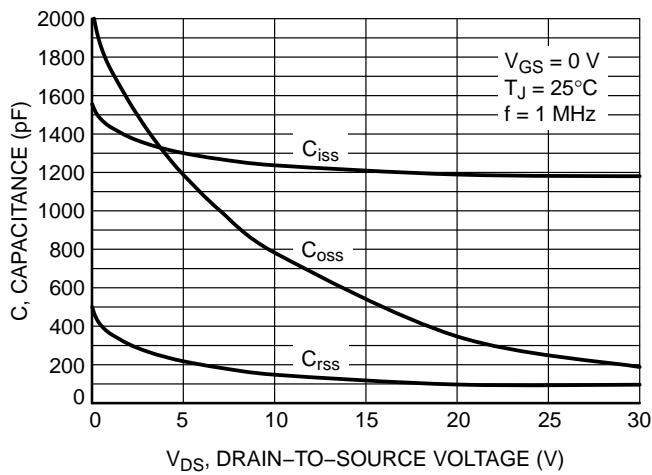
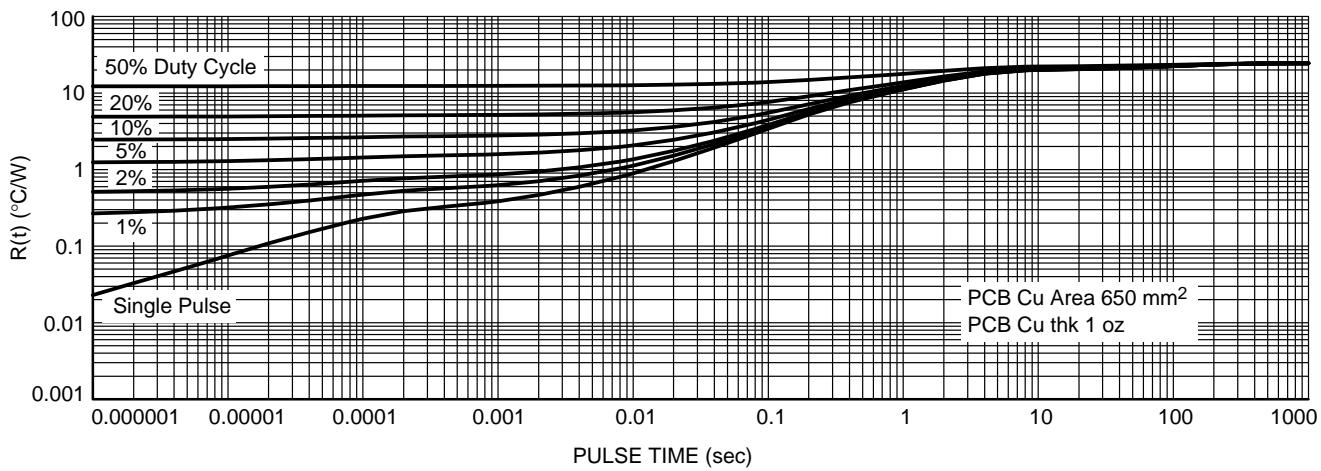
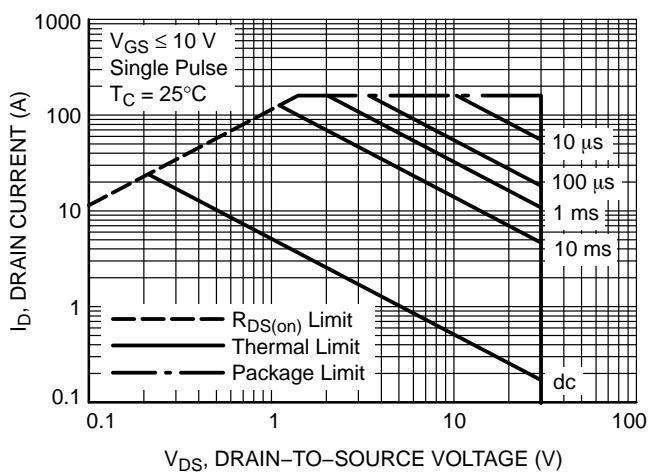
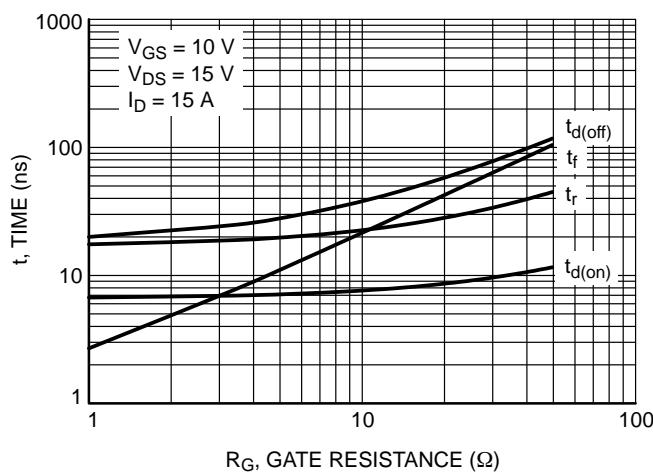
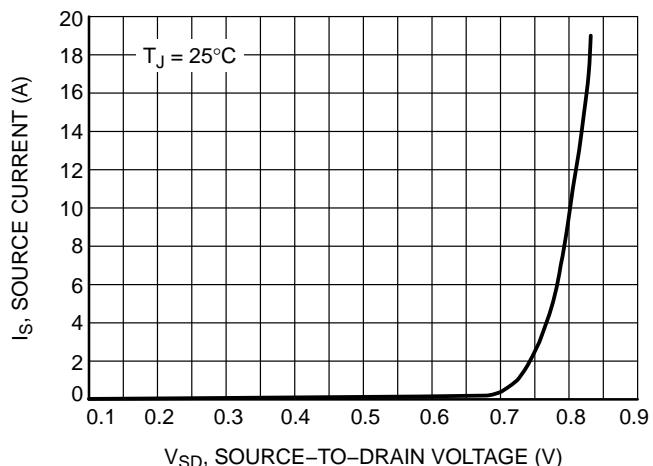
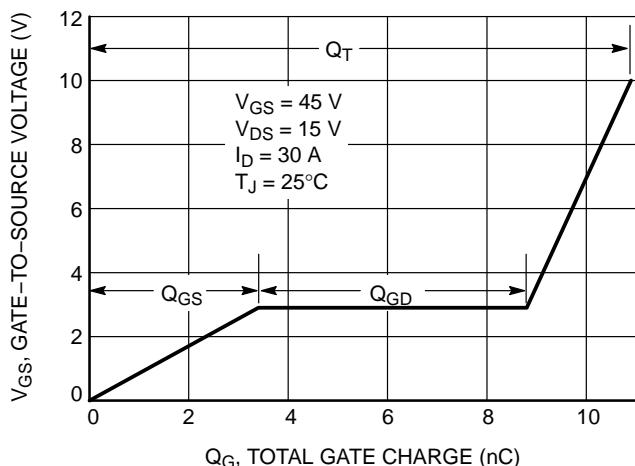


Figure 8. Capacitance Variation

TYPICAL CHARACTERISTICS – Q1



TYPICAL CHARACTERISTICS – Q2

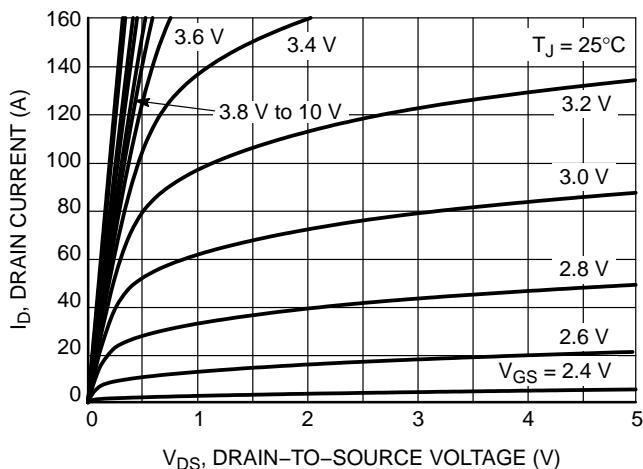


Figure 14. On-Region Characteristics

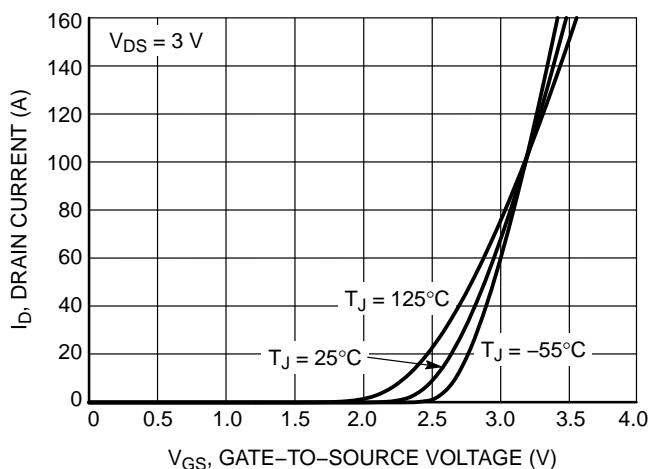


Figure 15. Transfer Characteristics

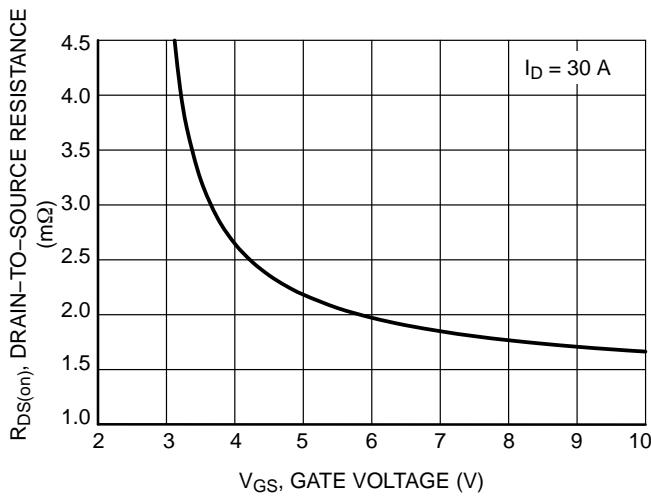


Figure 16. On-Resistance vs. Gate-to-Source Voltage

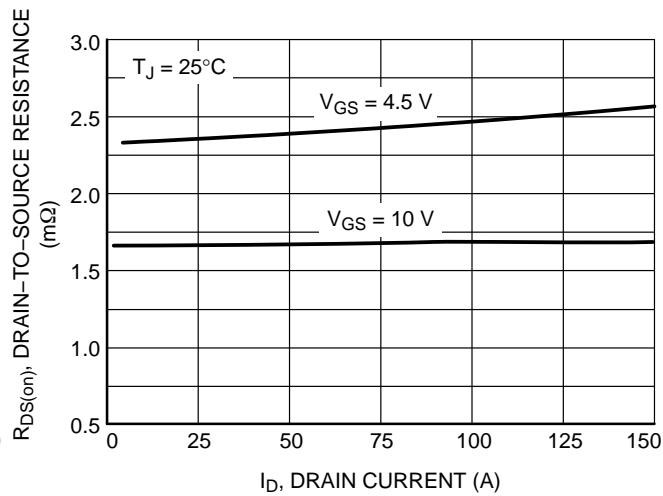


Figure 17. On-Resistance vs. Drain Current and Gate Voltage

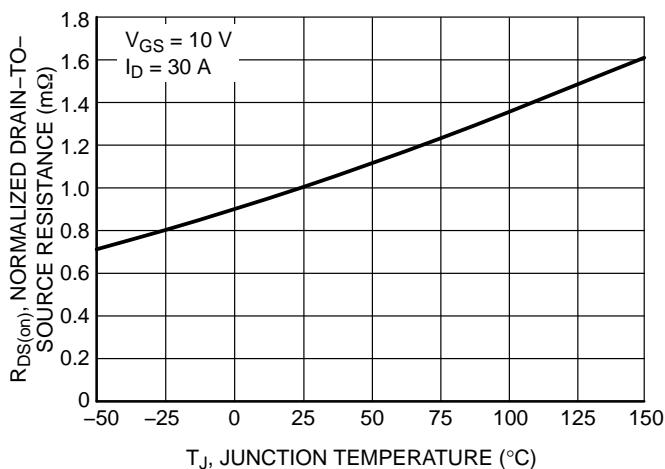


Figure 18. On-Resistance Variation with Temperature

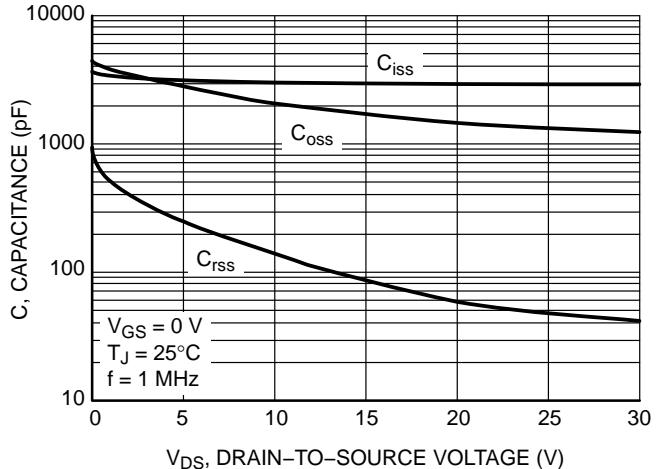


Figure 19. Capacitance Variation

TYPICAL CHARACTERISTICS – Q2

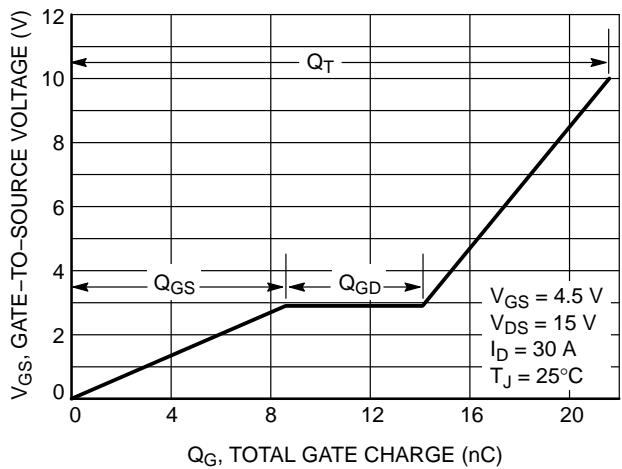


Figure 20. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

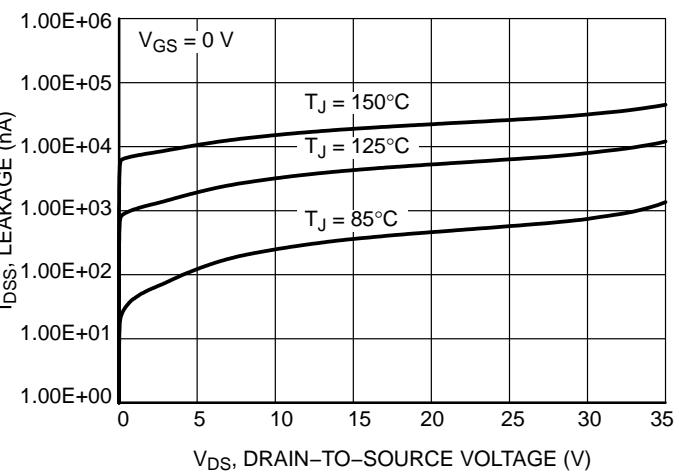


Figure 21. Drain-to-Source Leakage Current vs. Voltage

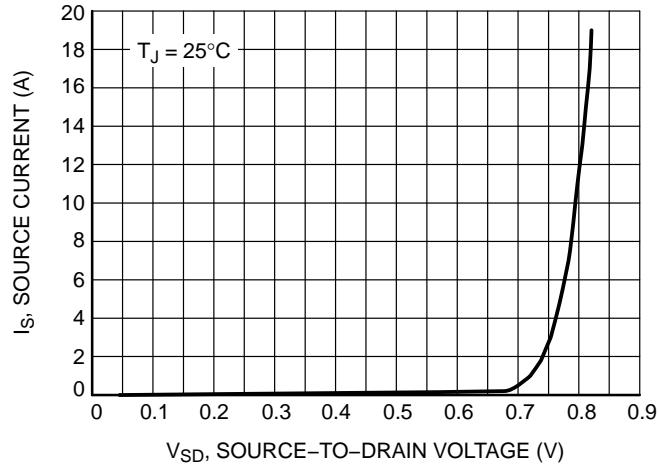
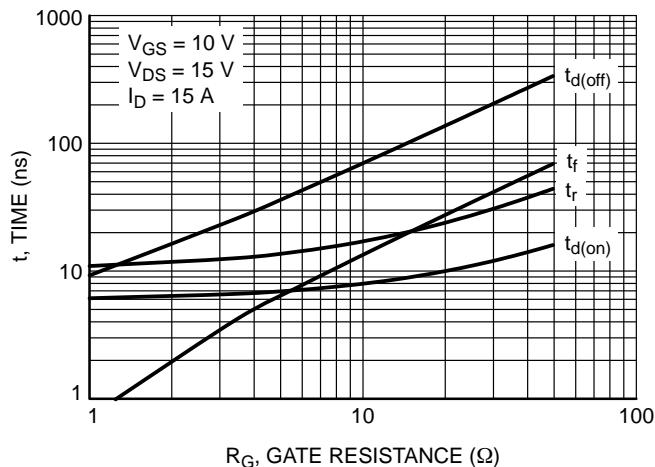
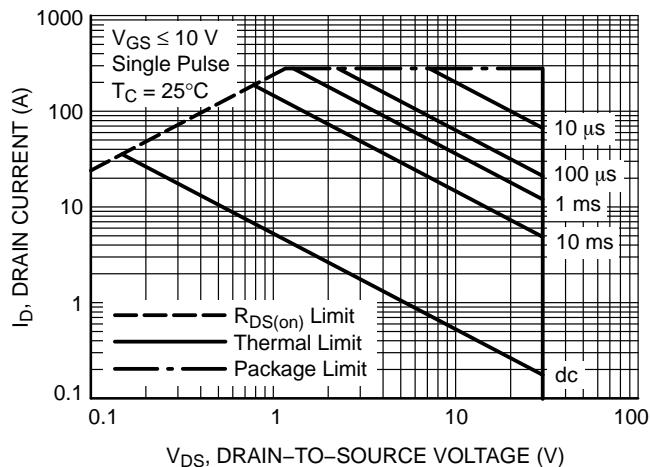
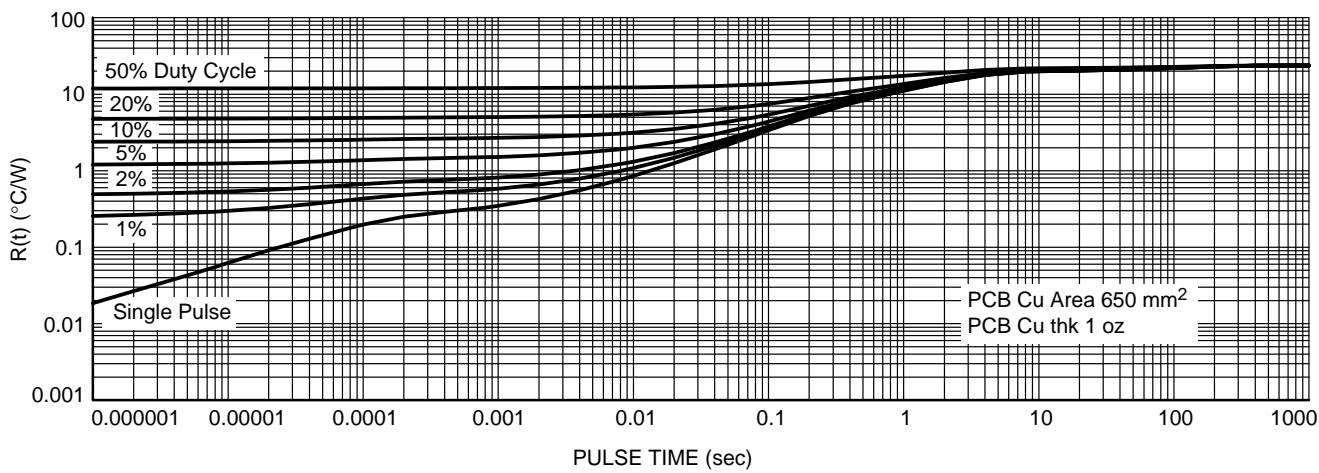


Figure 22. Diode Forward Voltage vs. Current

TYPICAL CHARACTERISTICS – Q2

Figure 23. Resistive Switching Time Variation vs. Gate Resistance

Figure 24. Maximum Rated Forward Biased Safe Operating Area

Figure 25. Thermal Characteristics
ORDERING INFORMATION

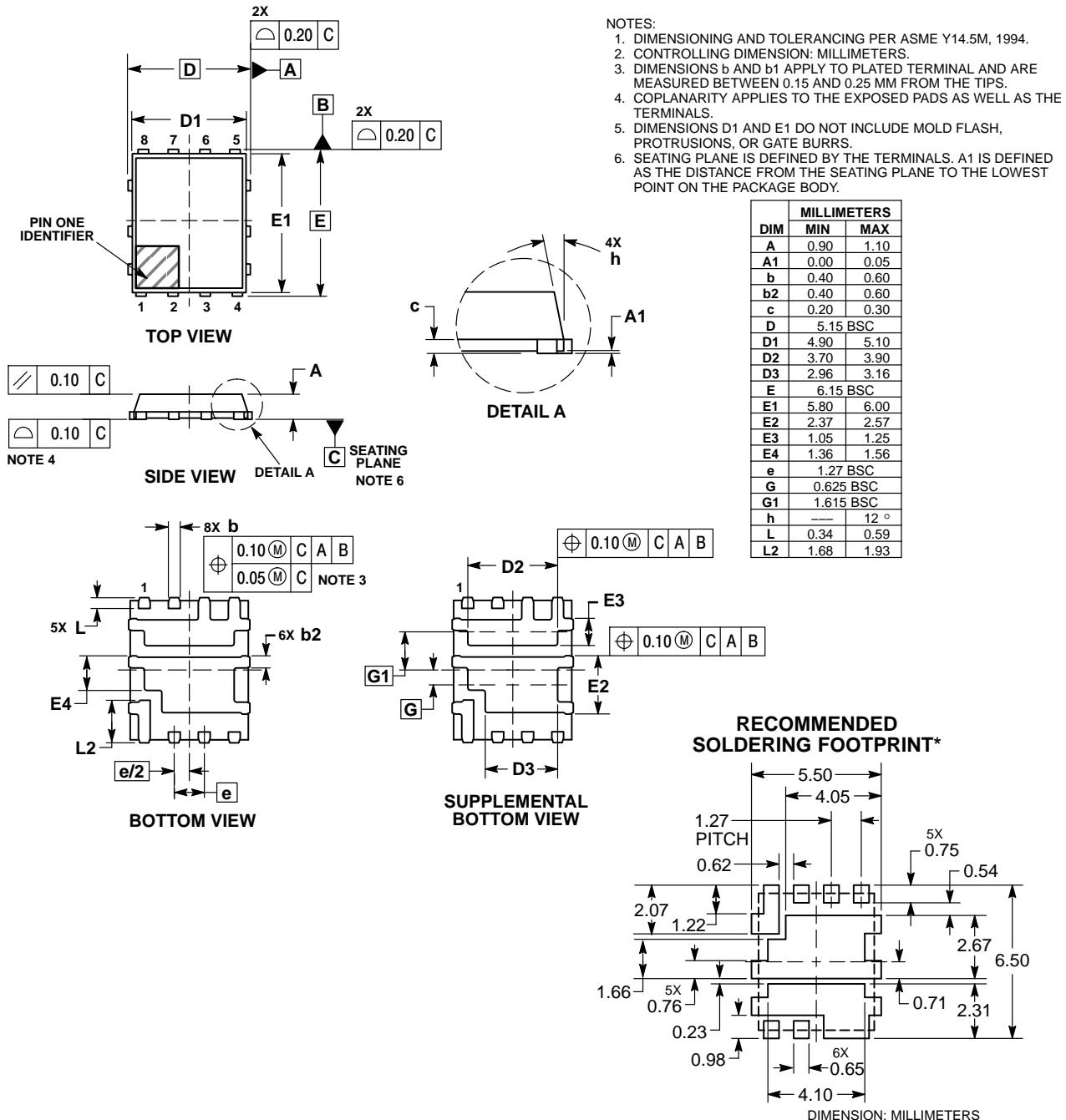
Device	Package	Shipping [†]
NTMFD4C86NT1G	DFN8 (Pb-Free)	1500 / Tape & Reel
NTMFD4C86NT3G	DFN8 (Pb-Free)	5000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

NTMFD4C86N

PACKAGE DIMENSIONS

DFN8 5x6, 1.27P PowerPhase FET CASE 506CR ISSUE C



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

ON Semiconductor and  are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and hold ON Semiconductor and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that ON Semiconductor was negligent regarding the design or manufacture of the part. ON Semiconductor is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor
19521 E. 32nd Pkwy, Aurora, Colorado 80011 USA
Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada
Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada
Email: orderlit@onsemi.com

N. American Technical Support: 800-282-9855 Toll Free

USA/Canada

Europe, Middle East and Africa Technical Support:

Phone: 421 33 790 2910

Japan Customer Focus Center

Phone: 81-3-5817-1050

ON Semiconductor Website: www.onsemi.com

Order Literature: <http://www.onsemi.com/orderlit>

For additional information, please contact your local
Sales Representative